

MOSFET

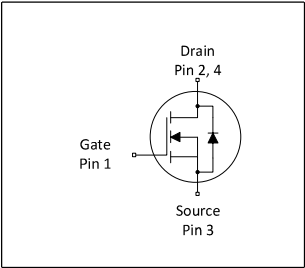
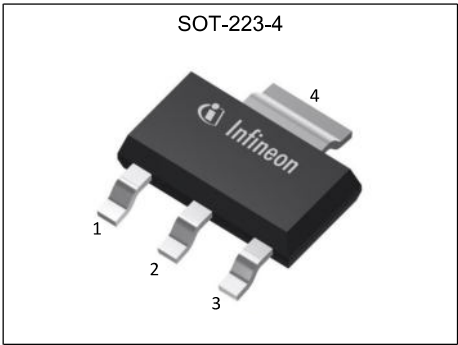
Small-Signal Transistor

Features

- N-channel
- Depletion mode
- dv/dt rated
- Halogen-free according to IEC61249-2-21
- Pb-free lead plating; RoHS compliant

Product validation

Fully qualified according to JEDEC for Industrial Applications



RoHS

Table 1 Key Performance Parameters

Parameter	Value	Unit
V_{DS}	600	V
$R_{DS(on),max}$	60	Ω
$I_{DSS,min}$	0.02	A
ESD Sensitivity, JESD22-A114 (HBM)	Class1A (>250V,<500V)	

Type / Ordering Code	Package	Marking	Related Links
BSP135I	PG-SOT223	SP135I	-

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1 Maximum ratings

at $T_A=25\text{ °C}$, unless otherwise specified

Table 2 Maximum ratings

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Continuous drain current	I_D	-	-	0.12 0.10	A	$T_A=25\text{ °C}$ $T_A=70\text{ °C}$
Pulsed drain current	$I_{D,pulse}$	-	-	0.48	A	$T_A=25\text{ °C}$
Reverse diode dv/dt	dv/dt	-	-	6	kV/ μ s	$I_D=0.12\text{ A}$, $V_{DS}=20\text{ V}$, di/dt=200 A/ μ s, $T_{j,max}=150\text{ °C}$
Gate source voltage	V_{GS}	-20	-	20	V	-
Power dissipation	P_{tot}	-	-	1.8	W	$T_A=25\text{ °C}$
Operating and storage temperature	T_j , T_{stg}	-55	-	150	°C	IEC climatic category; DIN IEC 68-1: 55/150/56

2 Thermal characteristics

Table 3 Thermal characteristics

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Thermal resistance, junction - soldering point (pin 4)	R_{thJS}	-	-	25	K/W	-
SMD version, device on PCB, minimal footprint	R_{thJA}	-	-	115	K/W	-
SMD version, device on PCB, 6 cm ² cooling area ¹⁾	R_{thJA}	-	-	70	K/W	-

3 Electrical characteristics

at $T_j=25\text{ °C}$, unless otherwise specified

Table 4 Static characteristics

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Drain-source breakdown voltage	$V_{(BR)DSS}$	600	-	-	V	$V_{GS}=-3\text{ V}$, $I_D=250\text{ }\mu$ A
Gate threshold voltage	$V_{GS(th)}$	-2.1	-1.4	-1	V	$V_{DS}=3\text{ V}$, $I_D=94\text{ }\mu$ A
Drain-source cutoff current	$I_{D(off)}$	-	-	0.1 10	μ A	$V_{DS}=600\text{ V}$, $V_{GS}=-3\text{ V}$, $T_j=25\text{ °C}$ $V_{DS}=600\text{ V}$, $V_{GS}=-3\text{ V}$, $T_j=125\text{ °C}$
Gate-source leakage current	I_{GSS}	-	-	100	nA	$V_{GS}=20\text{ V}$, $V_{DS}=0\text{ V}$
On-state drain current	I_{DSS}	20	-	-	mA	$V_{GS}=0\text{ V}$, $V_{DS}=10\text{ V}$
Drain-source on-state resistance	$R_{DS(on)}$	-	30 25	60 45	Ω	$V_{GS}=0\text{ V}$, $I_D=0.01\text{ A}$ $V_{GS}=10\text{ V}$, $I_D=0.12\text{ A}$
Transconductance	g_{fs}	0.08	0.16	-	S	$ V_{DS} >2 I_D R_{DS(on)max}$, $I_D=0.1\text{ A}$

¹⁾ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (single layer, 70 μ m thick) copper area for

Table 5 Dynamic characteristics

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Input capacitance	C_{iss}	-	98	-	pF	$V_{GS}=-3\text{ V}$, $V_{DS}=25\text{ V}$, $f=1\text{ MHz}$
Output capacitance	C_{oss}	-	8.5	-	pF	$V_{GS}=-3\text{ V}$, $V_{DS}=25\text{ V}$, $f=1\text{ MHz}$
Reverse transfer capacitance	C_{rss}	-	3.4	-	pF	$V_{GS}=-3\text{ V}$, $V_{DS}=25\text{ V}$, $f=1\text{ MHz}$
Turn-on delay time	$t_{d(on)}$	-	5.4	-	ns	$V_{DD}=300\text{ V}$, $V_{GS}=-3\text{ to }5\text{ V}$, $I_D=0.1\text{ A}$, $R_G=6\text{ }\Omega$
Rise time	t_r	-	5.6	-	ns	$V_{DD}=300\text{ V}$, $V_{GS}=-3\text{ to }5\text{ V}$, $I_D=0.1\text{ A}$, $R_G=6\text{ }\Omega$
Turn-off delay time	$t_{d(off)}$	-	28	-	ns	$V_{DD}=300\text{ V}$, $V_{GS}=-3\text{ to }5\text{ V}$, $I_D=0.1\text{ A}$, $R_G=6\text{ }\Omega$
Fall time	t_f	-	182	-	ns	$V_{DD}=300\text{ V}$, $V_{GS}=-3\text{ to }5\text{ V}$, $I_D=0.1\text{ A}$, $R_G=6\text{ }\Omega$

Table 6 Gate charge characteristics

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Gate to source charge	Q_{gs}	-	0.24	-	nC	$V_{DD}=400\text{ V}$, $I_D=0.1\text{ A}$, $V_{GS}=-3\text{ to }5\text{ V}$
Gate to drain charge	Q_{gd}	-	2.0	-	nC	$V_{DD}=400\text{ V}$, $I_D=0.1\text{ A}$, $V_{GS}=-3\text{ to }5\text{ V}$
Gate charge total	Q_g	-	3.7	-	nC	$V_{DD}=400\text{ V}$, $I_D=0.1\text{ A}$, $V_{GS}=-3\text{ to }5\text{ V}$
Gate plateau voltage	$V_{plateau}$	-	0.20	-	V	$V_{DD}=400\text{ V}$, $I_D=0.1\text{ A}$, $V_{GS}=-3\text{ to }5\text{ V}$

Table 7 Reverse diode

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Diode continuous forward current	I_S	-	-	0.12	A	$T_A=25\text{ }^\circ\text{C}$
Diode pulse current	$I_{S,pulse}$	-	-	0.48	A	$T_A=25\text{ }^\circ\text{C}$
Diode forward voltage	V_{SD}	-	0.78	1.2	V	$V_{GS}=-3\text{ V}$, $I_F=0.12\text{ A}$, $T_J=25\text{ }^\circ\text{C}$
Reverse recovery time	t_{rr}	-	87	130	ns	$V_R=300\text{ V}$, $I_F=0.1\text{ A}$, $di_F/dt=100\text{ A}/\mu\text{s}$
Reverse recovery charge	Q_{rr}	-	70	104	nC	$V_R=300\text{ V}$, $I_F=0.1\text{ A}$, $di_F/dt=100\text{ A}/\mu\text{s}$

4 Electrical characteristics diagrams

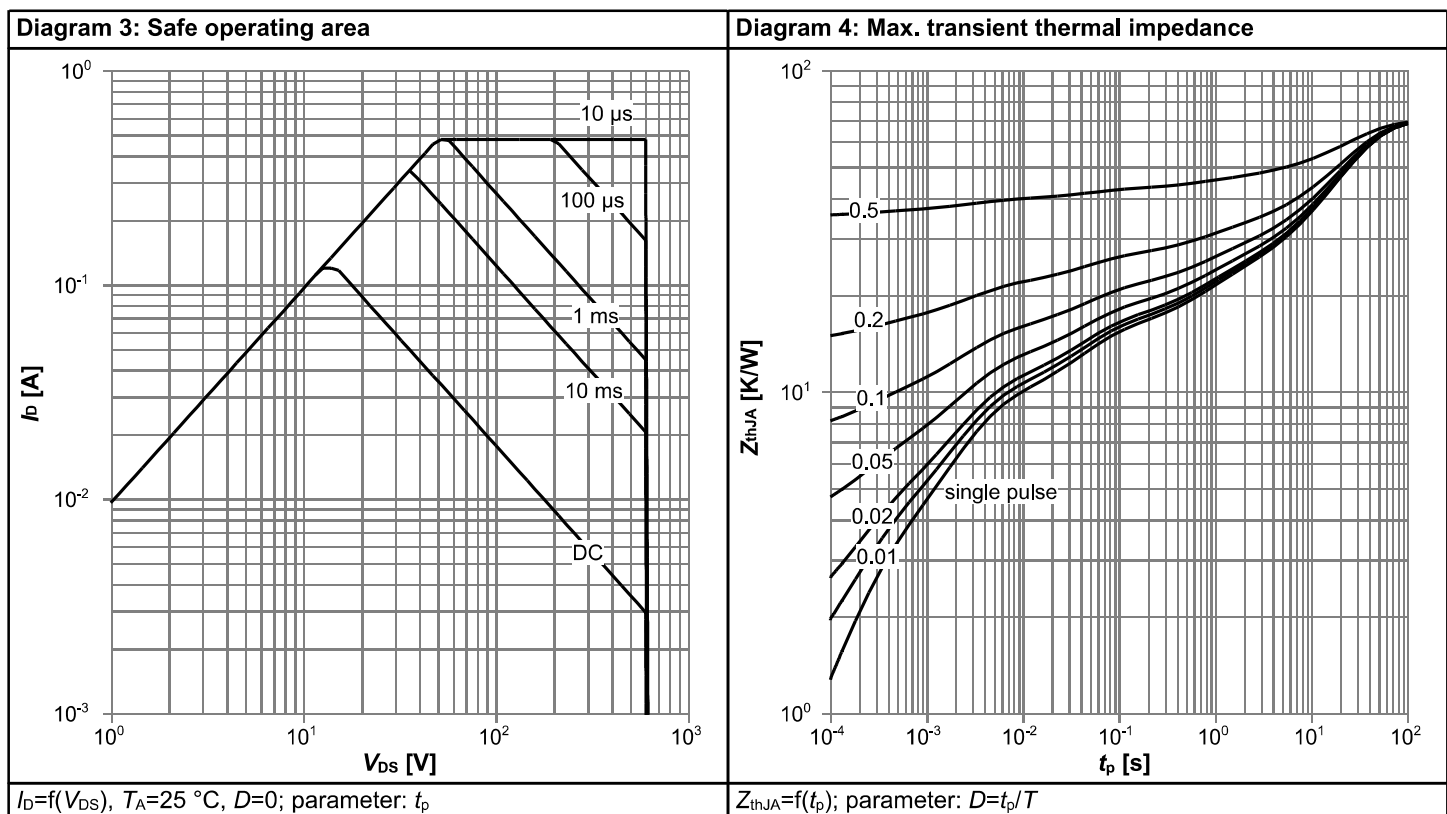
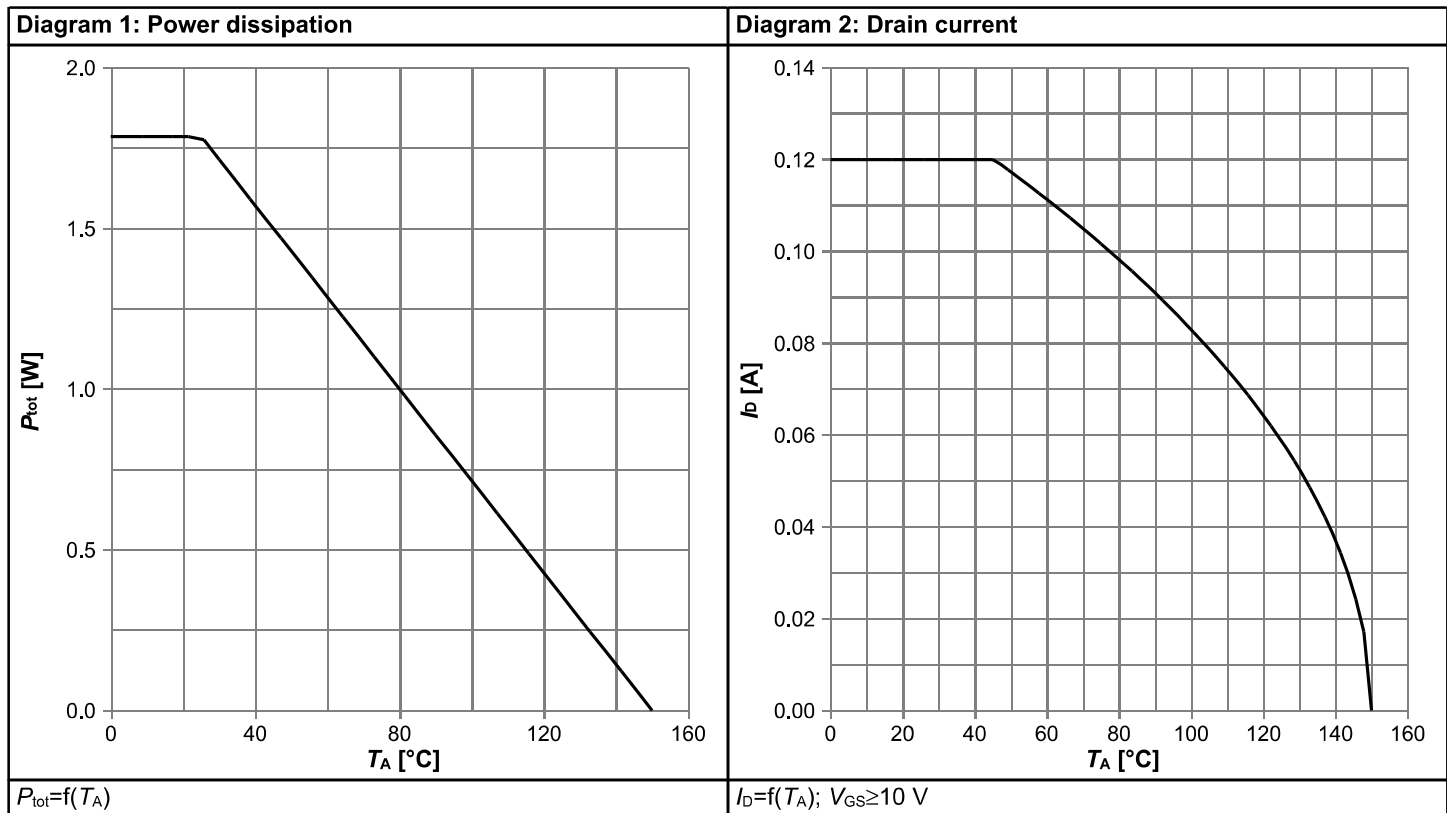
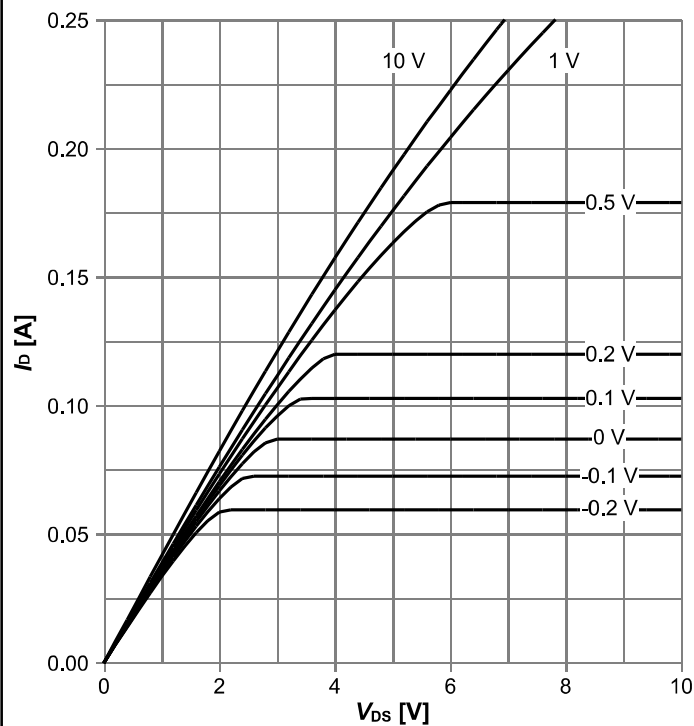
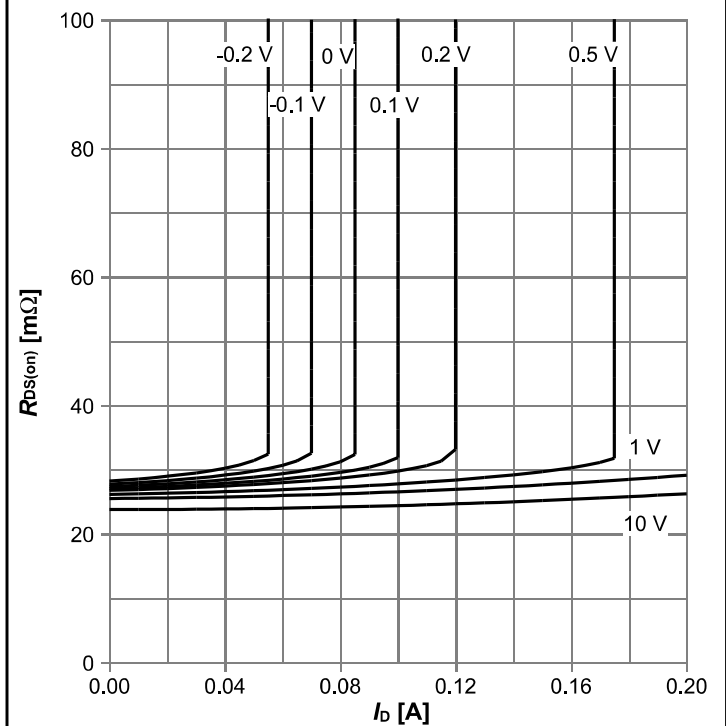


Diagram 5: Typ. output characteristics



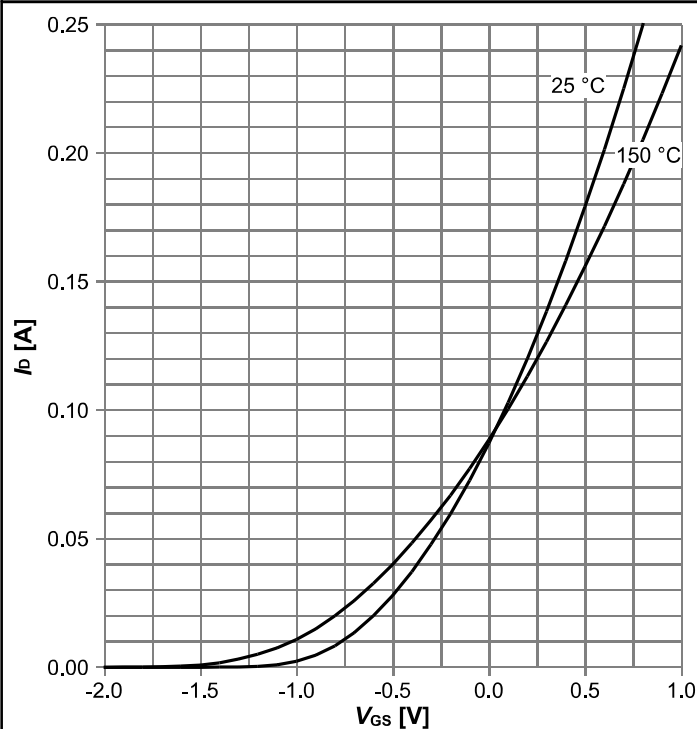
$I_D = f(V_{DS})$, $T_j = 25^\circ\text{C}$; parameter: V_{GS}

Diagram 6: Typ. drain-source on resistance



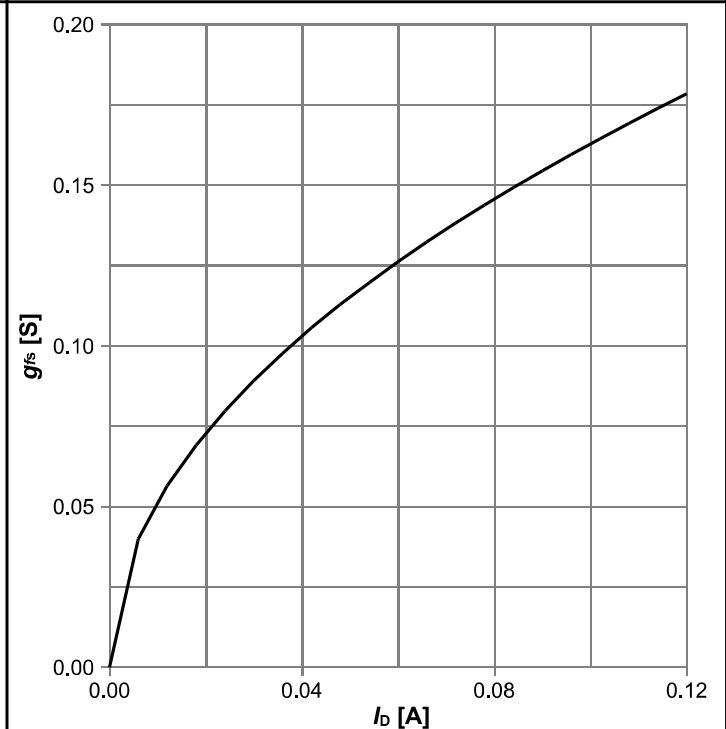
$R_{DS(on)} = f(I_D)$, $T_j = 25^\circ\text{C}$; parameter: V_{GS}

Diagram 7: Typ. transfer characteristics



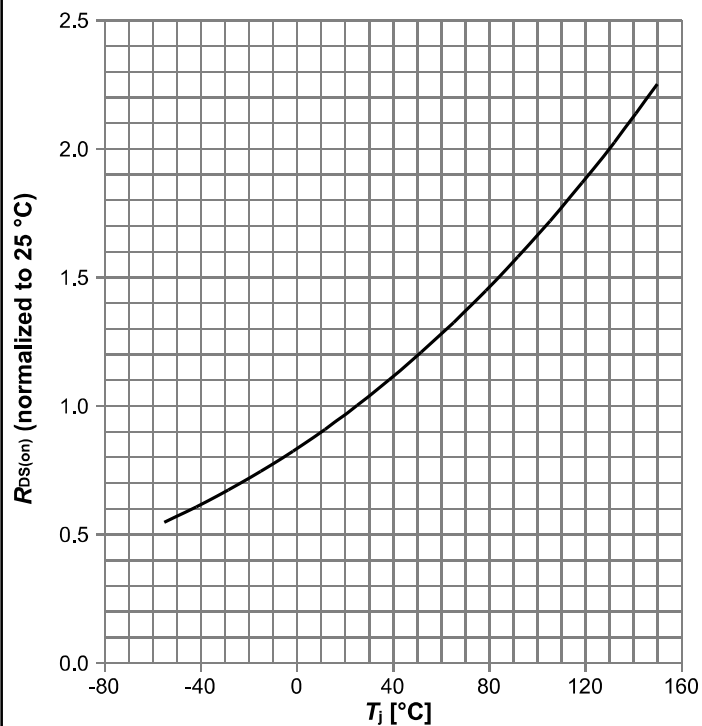
$I_D = f(V_{GS})$, $|V_{DS}| > 2|I_D|R_{DS(on)max}$; parameter: T_j

Diagram 8: Typ. transconductance



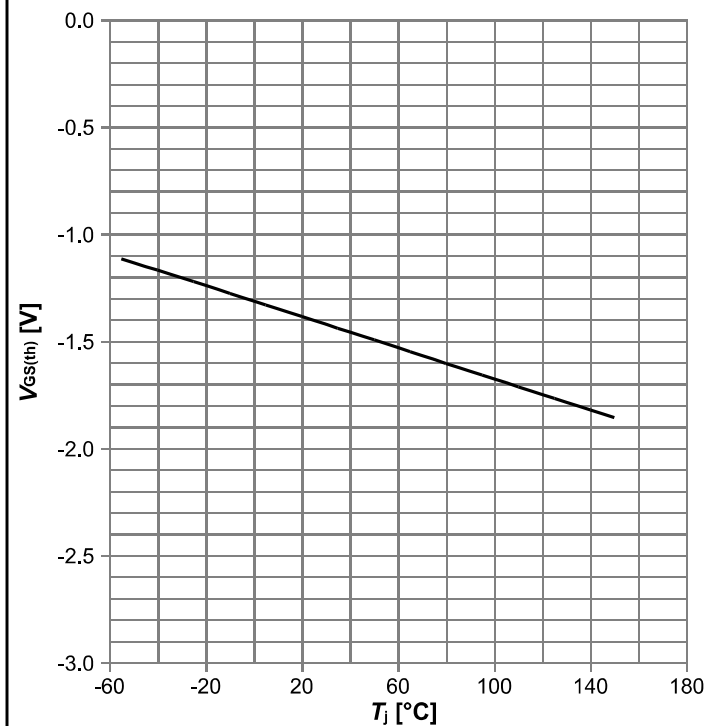
$g_{fs} = f(I_D)$

Diagram 9: Normalized drain-source on resistance



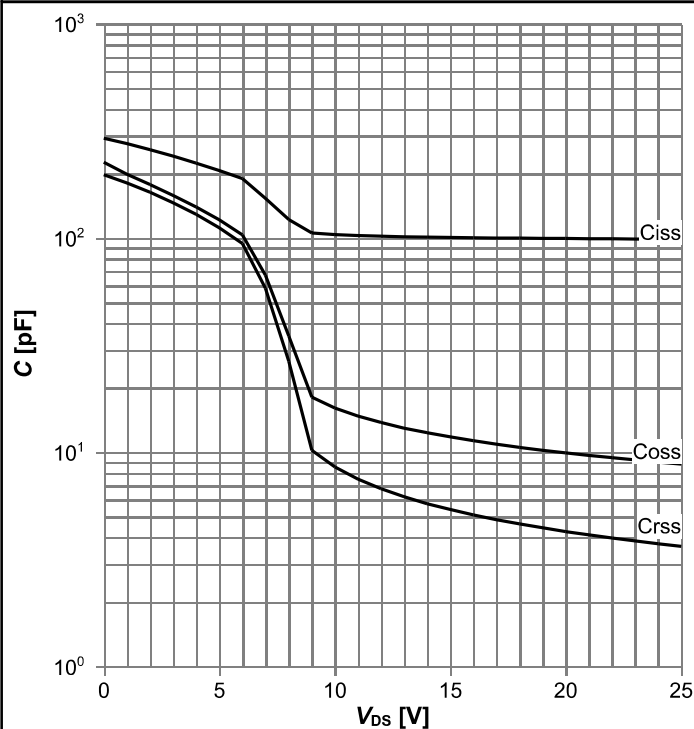
$$R_{DS(on)} = f(T_j), I_D = 0.01 \text{ A}, V_{GS} = 0 \text{ V}$$

Diagram 10: Typ. gate threshold voltage



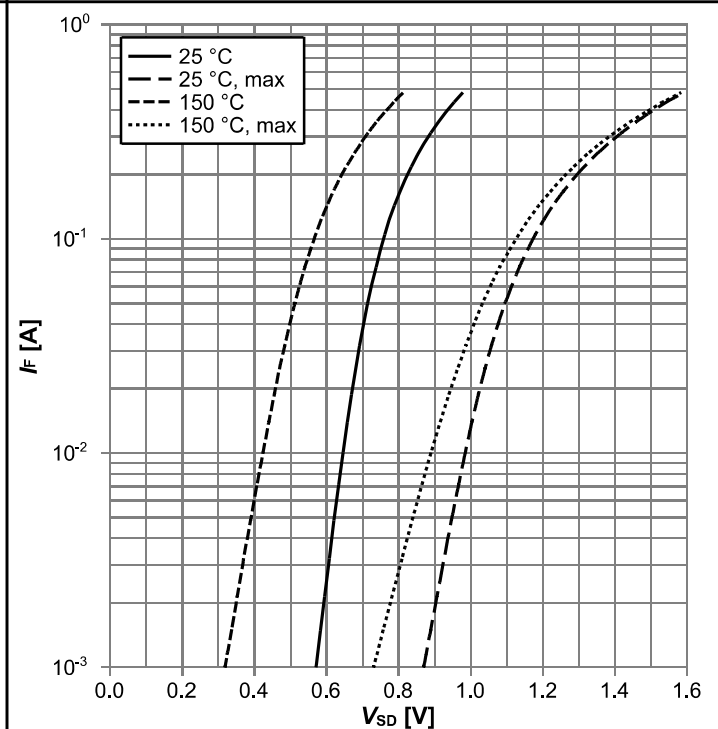
$$V_{GS(th)} = f(T_j), V_{DS} = 3 \text{ V}; I_D = 94 \text{ } \mu\text{A}$$

Diagram 11: Typ. capacitances



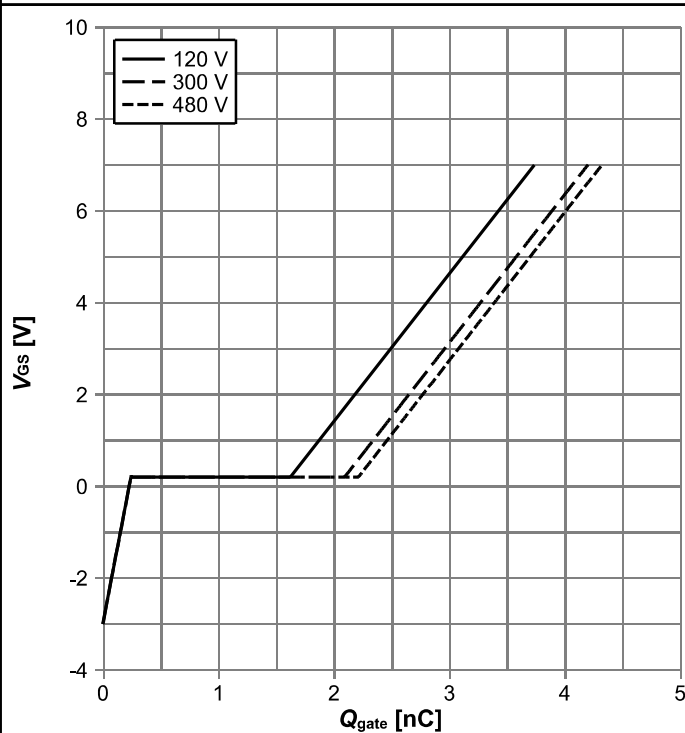
$$C = f(V_{DS}), V_{GS} = -3 \text{ V}; f = 1 \text{ MHz}$$

Diagram 12: Forward characteristics of reverse diode



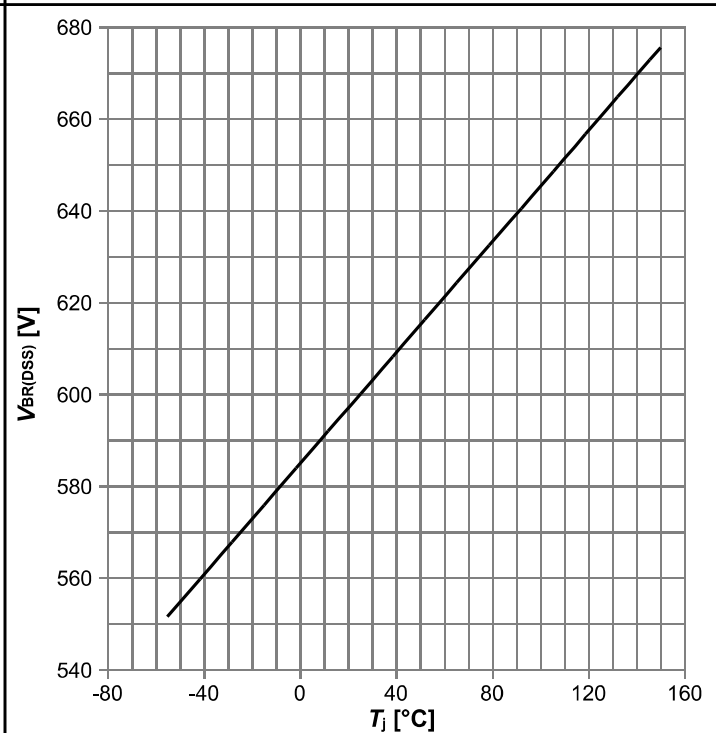
$$I_F = f(V_{SD}), V_{GS} = -3 \text{ V}; \text{parameter: } T_j$$

Diagram 13: Typ. gate charge



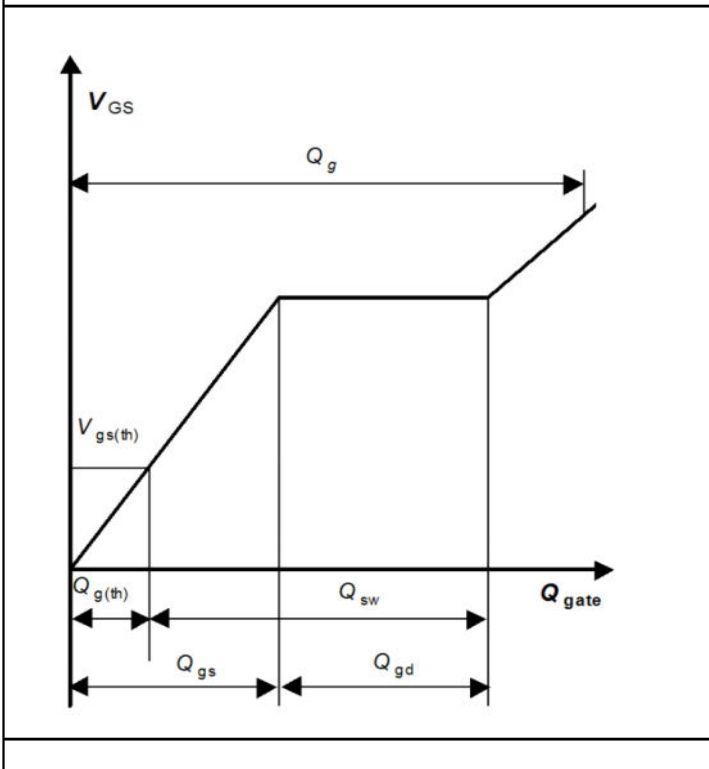
$V_{GS}=f(Q_{gate}); I_D=0.1 \text{ A pulsed}$

Diagram 14: Drain-source breakdown voltage

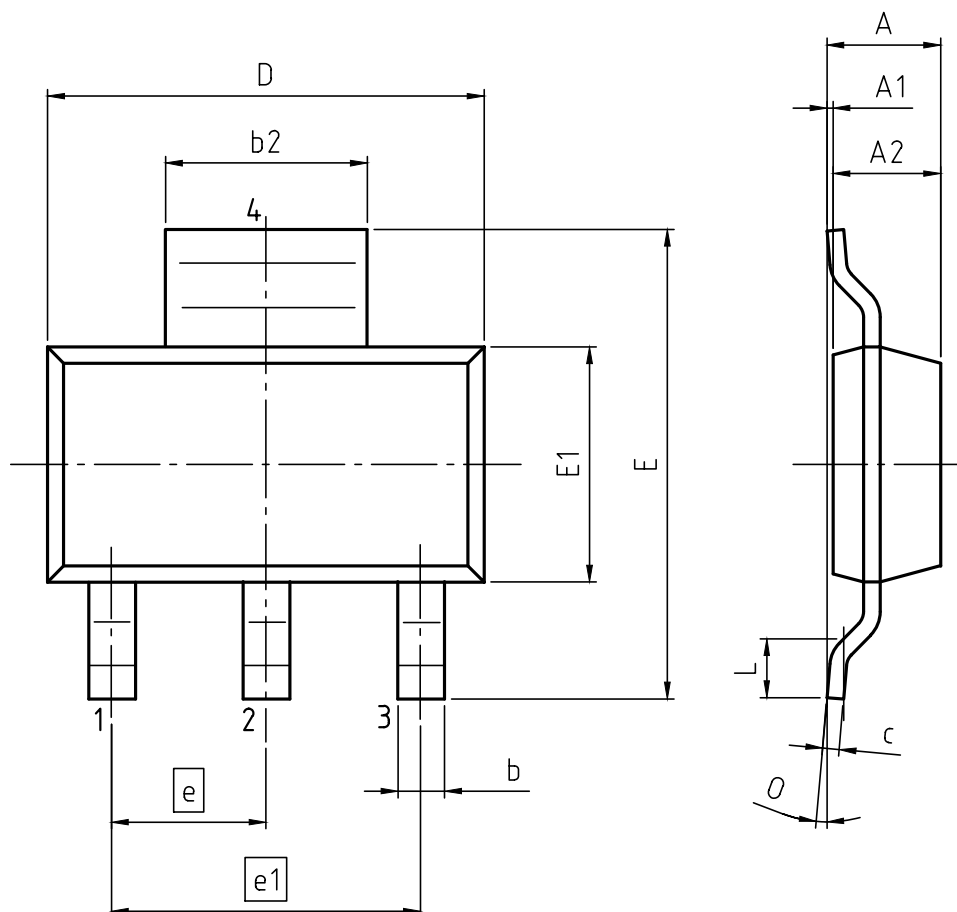


$V_{BR(DSS)}=f(T_j); I_D=250 \text{ } \mu\text{A}, V_{GS}=-3\text{V}$

Diagram Gate charge waveforms



5 Package Outlines



PACKAGE - GROUP NUMBER: PG-SOT223-4-U01		
REVISION: 01		DATE: 07.12.2020
DIMENSIONS	MILLIMETERS	
	MIN.	MAX.
A	1.60	1.80
A1	-	0.10
A2	1.50	1.70
b	0.60	0.80
b1	0.61	1.45
b2	2.90	3.10
c	0.24	0.35
D	6.30	6.70
E	6.70	7.30
E1	3.30	3.70
e	2.30	
e1	4.60	
L	MIN. 0.75	
O	0°	10°

Figure 1 Outline PG-SOT223, dimensions in mm

Revision History

BSP135I

Revision: 2021-03-16, Rev. 2.1

Previous Revision

Revision	Date	Subjects (major changes since last revision)
2.0	2021-01-25	Release of final version
2.1	2021-03-16	Update technology naming

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